Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10572725	HAN ET AL.
Examiner	Art Unit
Hsieh, Ping Y	2618

SEARCHED			
Class	Subclass	Date	Examiner
455	76, 85, 86, 87, 118, 147, 148, 165.1, 183.1, 323, 324	8/31/09	PH

SEARCH NOTES		
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Text search in EAST (see search history)	8/31/09	PH
PLUS search	1/28/08	PH
Consulted with Yuwen Pan, Wen Huang	11/12/08	PH

INTERFERENCE SEARCH			
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